

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Kiyoshi Mita	Art Unit : 2815
Serial No. : 10/813,782	Examiner : Chris C. Chu
Filed : March 31, 2004	Conf. No. : 5223
Title : SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING THE SAME	

MAIL STOP RCE

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT


Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature, if any, are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

Listed reference AA (USPN 6,720,209) is the corresponding English reference for foreign listed reference AF (KR 10-2002-0033938).

This filing is being made with the filing of a Request for Continued Examination. No fee is required. However, please apply any charges or credits to deposit account 06 1050.

Respectfully submitted,

Date: 9/21/06



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Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 14225-049001	Application No. 10/813,782
	Applicant Kiyoshi Mita		
	Filing Date March 31, 2004	Group Art Unit 2815	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	6,720,209	04/13/2004	Igarashi et al.			
	AB						
	AC						
	AD						
	AE						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AF	KR-10-2002-0033938	12/31/2002	Korea				X
	AG							
	AH							
	AI							
	AJ							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AK	
	AL	
	AM	
	AN	
	AO	
	AP	
	AQ	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	